

INTERNATIONAL STANDARD

NORME INTERNATIONALE

**Metallic communication cable test methods –
Part 4-7: Electromagnetic compatibility (EMC) – Test method for measuring of
transfer impedance Z_T and screening attenuation a_s or coupling attenuation a_c
of connectors and assemblies up to and above 3 GHz – Triaxial tube in tube
method**

**Méthodes d'essai des câbles métalliques de communication –
Partie 4-7: Compatibilité électromagnétique (CEM) – Méthode d'essai pour
mesurer l'impédance de transfert Z_T et l'affaiblissement d'écrantage a_s ou
l'affaiblissement de couplage a_c des connecteurs et des cordons jusqu'à 3 GHz
et au-dessus – Méthode triaxiale en tubes concentriques**



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INTERNATIONAL ELECTROTECHNICAL COMMISSION

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FOREWORD

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International Standard IEC 62153-4-7 has been prepared by IEC technical committee 46: Cables, wires, waveguides, R.F. connectors, R.F. and microwave passive components and accessories.

This second edition cancels and replaces the first edition published in 2006. This edition constitutes a technical revision.

This edition includes the following significant technical changes with respect to the previous edition:

The document is revised and updated. The changes of the revised IEC 62153-4-3:2013, and IEC 62153-4-4:2015, are included.

Measurements can be achieved now with mismatch at the generator site, impedance matching devices are not necessary.

This bilingual version (2016-03) corresponds to the monolingual English version, published in 2015-12.

The text of this standard is based on the following documents:

FDIS	Report on voting
46/572/FDIS	46/585/RVD

Full information on the voting for the approval of this standard can be found in the report on voting indicated in the above table.

The French version of this standard has not been voted upon.

This publication has been drafted in accordance with the ISO/IEC Directives, Part 2.

A list of all parts of the IEC 62153 series, under the general title: *Metallic communication cable test methods*, can be found on the IEC website.

The committee has decided that the contents of this publication will remain unchanged until the stability date indicated on the IEC website under "<http://webstore.iec.ch>" in the data related to the specific publication. At this date, the publication will be

- reconfirmed,
- withdrawn,
- replaced by a revised edition, or
- amended.

The contents of the corrigendum of April 2016 have been included in this copy.

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INTRODUCTION

The shielded screening attenuation test set-up according to IEC 62153-4-3 and IEC 62153-4-4 have been extended to take into account the particularities of electrically short elements like connectors and cable assemblies. Due to the concentric outer tube of the triaxial set-up, measurements are independent of irregularities on the circumference and outer electromagnetic fields.

With the use of an additional resonator tube (inner tube respectively tube in tube), a system is created where the screening effectiveness of an electrically short device is measured in realistic and controlled conditions. Also a lower cut off frequency for the transition between electrically short (transfer impedance Z_T) and electrically long (screening attenuation a_S) can be achieved.

A wide dynamic and frequency range can be applied to test even super screened connectors and assemblies with normal instrumentation from low frequencies up to the limit of defined transversal waves in the outer circuit at approximately 4 GHz.

Withdrawing